

**Search Notes**

Application/Control No.

10/699,233

Examiner

Leigh C. Maier

Applicant(s)/Patent under  
Reexamination

MAYER ET AL.

Art Unit

1623

**SEARCHED**

Class	Subclass	Date	Examiner
514	24 25 42 53	11/22/2005	LCM

**INTERFERENCE SEARCHED**

Class	Subclass	Date	Examiner

**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
-Reviewed search and prosecution in parent application 09/449,003 -EAST (transcript attached)	11/22/2005	LCM